

TOSHIBA Field Effect Transistor Silicon N Channel Junction Type

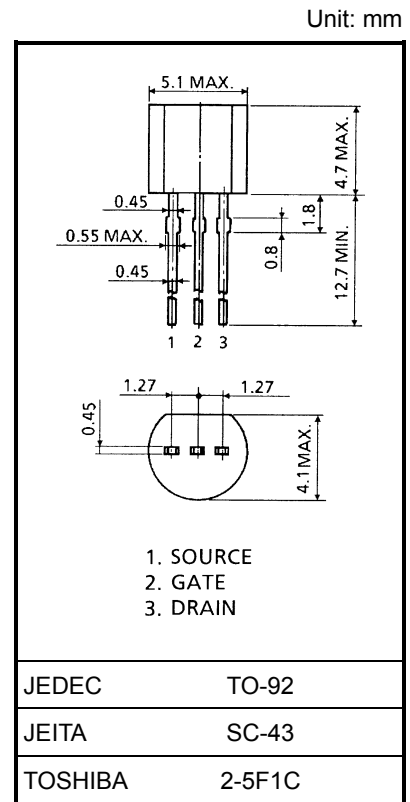
2SK30ATM

Low Noise Pre-Amplifier, Tone Control Amplifier and DC-AC High Input Impedance Amplifier Circuit Applications

- High breakdown voltage: $V_{GDS} = -50$ V
- High input impedance: $I_{GSS} = -1$ nA (max) ($V_{GS} = -30$ V)
- Low noise: $NF = 0.5$ dB (typ.)
($V_{DS} = 15$ V, $V_{GS} = 0$, $R_G = 100$ k Ω , $f = 120$ Hz)

Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Gate-drain voltage	V_{GDS}	-50	V
Gate current	I_G	10	mA
Drain power dissipation	P_D	100	mW
Junction temperature	T_j	125	°C
Storage temperature range	T_{stg}	-55~125	°C



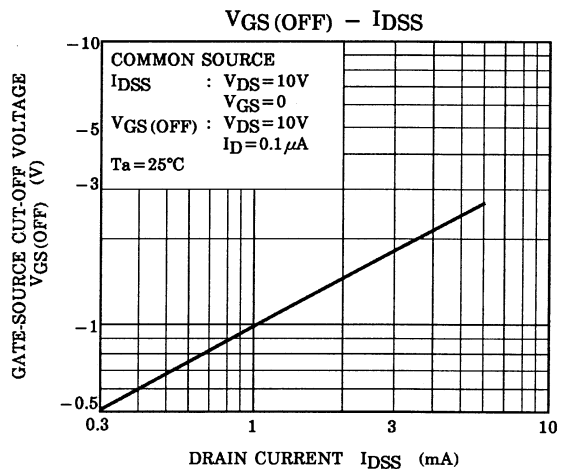
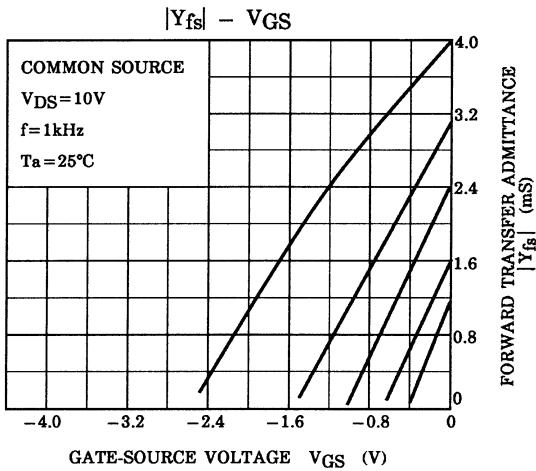
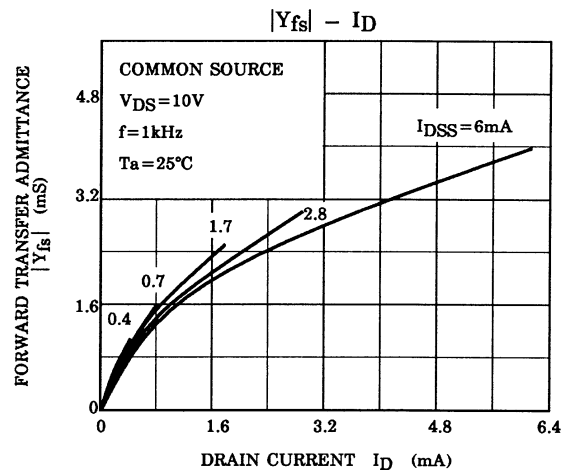
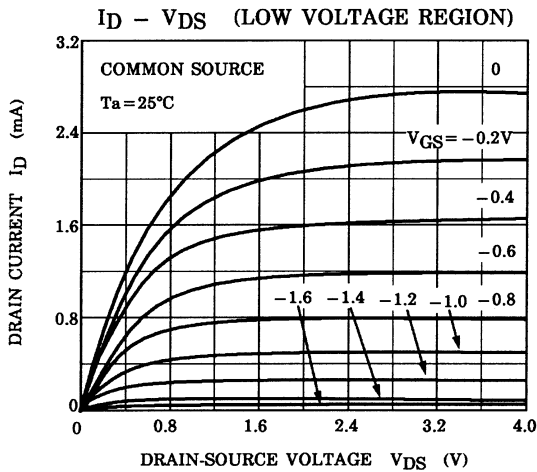
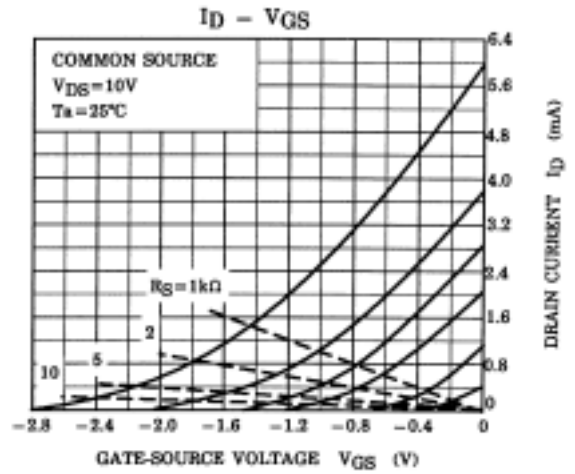
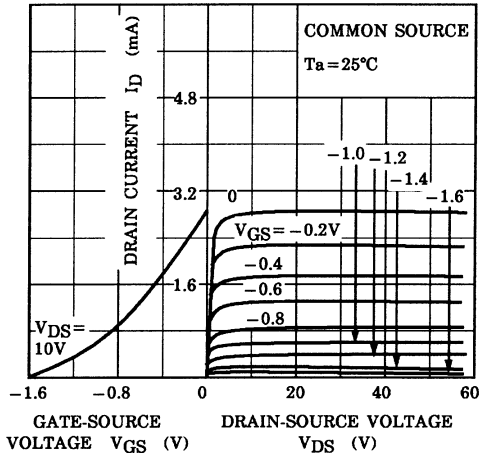
Weight: 0.21 g (typ.)

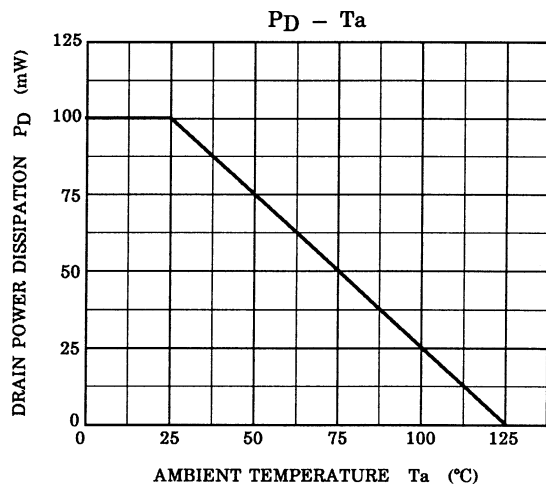
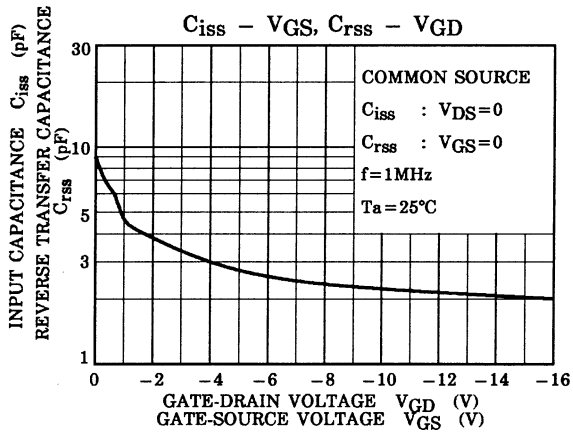
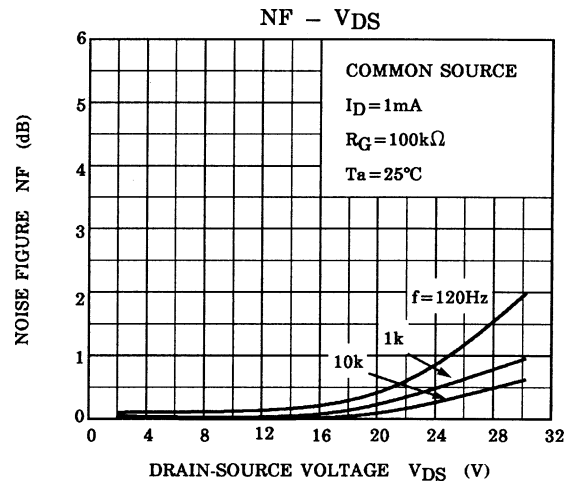
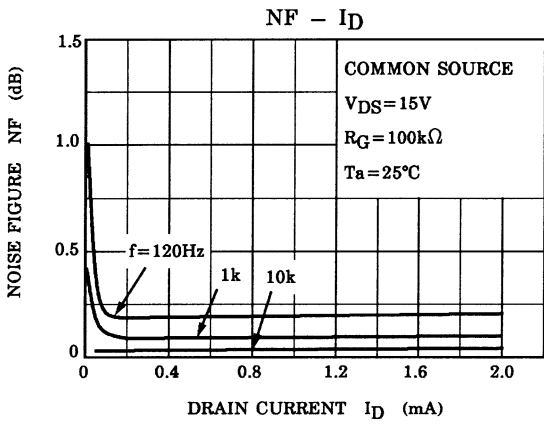
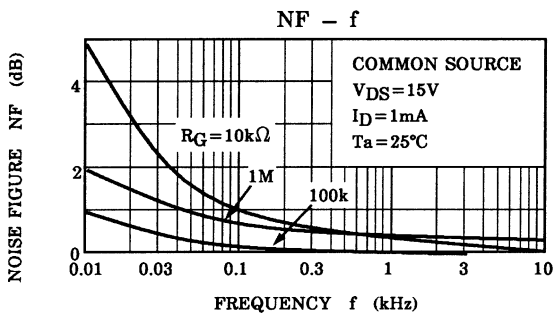
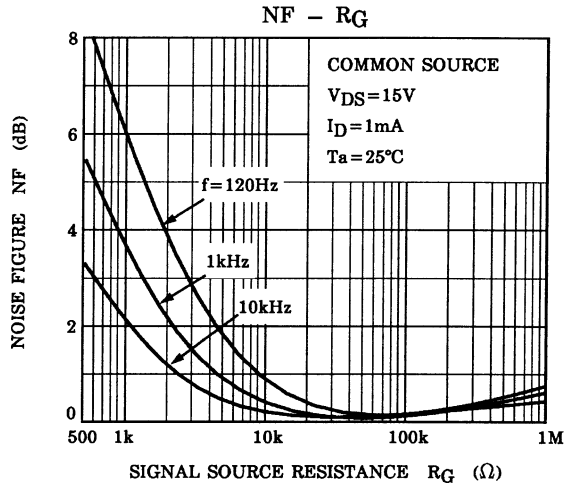
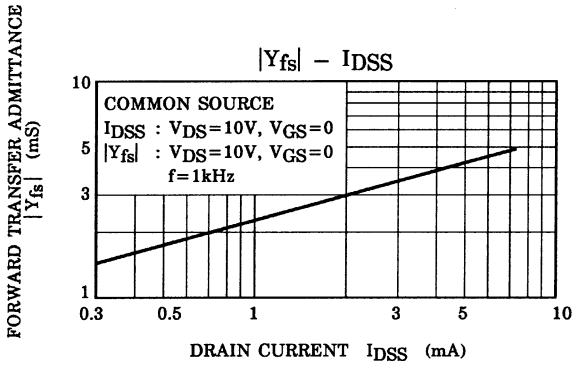
Electrical Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Gate cut-off current	I_{GSS}	$V_{GS} = -30$ V, $V_{DS} = 0$	—	—	-1.0	nA
Gate-drain breakdown voltage	$V_{(BR)GDS}$	$V_{DS} = 0$, $I_G = -100$ μ A	-50	—	—	V
Drain current	I_{DSS} (Note)	$V_{DS} = 10$ V, $V_{GS} = 0$	0.3	—	6.5	mA
Gate-source cut-off voltage	$V_{GS(OFF)}$	$V_{DS} = 10$ V, $I_D = 0.1$ μ A	-0.4	—	-5.0	V
Forward transfer admittance	$ Y_{fs} $	$V_{DS} = 10$ V, $V_{GS} = 0$, $f = 1$ kHz	1.2	—	—	mS
Input capacitance	C_{iss}	$V_{GS} = 0$, $V_{DS} = 0$, $f = 1$ MHz	—	8.2	—	pF
Reverse transfer capacitance	C_{rss}	$V_{GD} = -10$ V, $V_{DS} = 0$, $f = 1$ MHz	—	2.6	—	pF
Noise figure	NF	$V_{DS} = 15$ V, $V_{GS} = 0$ $R_G = 100$ k Ω , $f = 120$ Hz	—	0.5	5.0	dB

Note: I_{DSS} classification R: 0.30~0.75, O: 0.60~1.40, Y: 1.20~3.00, GR: 2.60~6.50

STATIC CHARACTERISTICS





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